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QNP-XY Series

Two-Axis, XY, Piezo Nanopositioning Stages

Travel ranges from 100 µm to 600 µm available

Long device lifetime

High-precision, frictionless flexure guidance system

Superior positioning resolution and linearity to 0.007% with direct-metrology capacitive sensor options

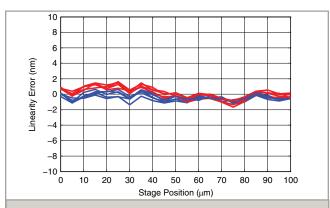
Mounting compatibility with other QNP-series piezo nanopositioners

Open-loop and vacuum versions

Aerotech's QNPTM-series of piezo nanopositioning stages offers nanometer-level performance in a compact, high-stiffness package. A variety of travel (100 μ m to 600 μ m) and feedback options make this the ideal solution for applications ranging from microscopy to optics alignment.

High Quality in a Compact Package

The QNP piezo stages are guided by precision flexures that are optimized using finite element analysis to ensure high-stiffness and long device life. The resulting design offers outstanding stiffness and resonant frequency enabling high process throughput and fast closed-loop response. Furthermore, the integrated XY package minimizes stage stack height and moving mass, resulting in superior static and dynamic multiaxis performance.



QNP40XY-100-C upper-axis linearity error plot measured with a laser interferometer over multiple bidirectional runs. The linearity measured is <0.002%. All sizes of the QNP stage series exhibit exceptional linearity and repeatability.

Aerotech's QNP-XY series of two-axis piezo nanopositioners offers closed-loop travel options of 100, 250, and 500 µm.

High-Resolution and Positioning Accuracy

All of the QNP piezo stages have the option of closed-loop feedback using a unique capacitive sensor design that allows for sub-nanometer resolution and high linearity. The capacitive sensors measure the output of the positioning carriage directly, enabling superior accuracy and repeatability.

Ultra-Precision Control

When coupled with Aerotech's Q-series controllers and drives, the QNP piezo nanopositioning stages demonstrate subnanometer positioning resolution and in-position stability (jitter), and high-positioning bandwidth. Software options such as Aerotech's Dynamic Controls Toolbox and Motion Designer packages provide a host of advanced yet easy-to-use tools such as Learning Control, Harmonic Cancellation, and Command Shaping, providing improved tracking errors and faster stepand-settle times.

Automatic parameter and calibration identification is accomplished using Aerotech's FlashConfig feature. The stage is automatically identified and all operational parameters including axis calibration data are uploaded into the controller ensuring safe, accurate and true "plug-and-play" operation.

Design Flexibility

Aerotech's QNP piezo stages are available with capacitance sensor feedback or without feedback (open-loop). Open-loop provides a cost-effective option for applications where compact size, high-dynamics, and sub-nanometer positioning resolution are required, but absolute positioning accuracy and repeatability are not required. Open-loop designs can also be used where the piezo position is controlled via an external feedback source (interferometer, vision system, photodetector, etc.).

An optional mounting plate provides direct mounting to English or metric breadboard optical tables. The QNP-series also includes the -L and -Z stages in which common travels mount together with adapter plates.

All QNP piezo stages are available in vacuum-prepared versions upon request.

QNP-XY SPECIFICATIONS

Mechanical Specifications Closed-Loop Travel		QNP40XY-100	QNP50XY-250 250 μm	QNP60XY-500 500 μm
Resolution ⁽²⁾	Closed-Loop	0.30 nm	0.50 nm	0.90 nm
	Open-Loop	0.15 nm	0.20 nm	0.40 nm
Linearity ^(3,4)		0.01%	0.01%	0.007%
Bidirectional Repeatability ⁽⁵⁾		2 nm	2 nm	5 nm
Pitch/Yaw		6 µrad (1.2 arc sec)	6 µrad (1.2 arc sec)	12 µrad (2.5 arc sec)
Stiffness (In Direction of Motion) ⁽⁶⁾		1.05 N/µm	0.36 N/µm	0.24 N/µm
Unloaded Personant Errogueneur(6)	Top Axis	885 Hz	445 Hz	315 Hz
Unloaded Resonant Frequency ⁽⁶⁾	Bottom Axis	635 Hz	295 Hz	200 Hz
Resonant Frequency (50 gram load) ⁽⁶⁾	Top Axis	495 Hz	305 Hz	240 Hz
	Bottom Axis	335 Hz	240 Hz	170 Hz
	Top Axis	370 m/s ²	370 m/s ²	210 m/s ²
Maximum Acceleration (Unloaded) ⁸⁾	Bottom Axis	320 m/s ²	160 m/s²	90 m/s ²
Moving Mass (Unloaded)	Top Axis	42 g	56 g	98 g
	Bottom Axis	79 g	126 g	217 g
Max Payload ⁽⁷⁾		1 kg	1 kg	1 kg
Stage Mass		0.11 kg	0.17 kg	0.27 kg
Material		Anodized Aluminum ⁽⁹⁾		
MTBF (Mean Time Between Failure)		30,000 Hours		

Notes:

1. Value ±10%.

 Value ±10%.
See Piezo Engineering Reference section 4.2 for description of resolution.
Certified with each stage (closed-loop feedback models only).
Measured approximately 15 mm above the carriage by an external metrology device. See Piezo Engineering Reference section 4.1 for description of linearity specifications.
Specified as a 1 sigma (standard deviation) value (closed-loop feedback models only). See Piezo Engineering Reference section 4.3 for description of bidirectional repeatability. 6. Values ±20%.
7. On-axis loading listed.
8. Requires selection of an appropriate amplifier to achieve listed values.

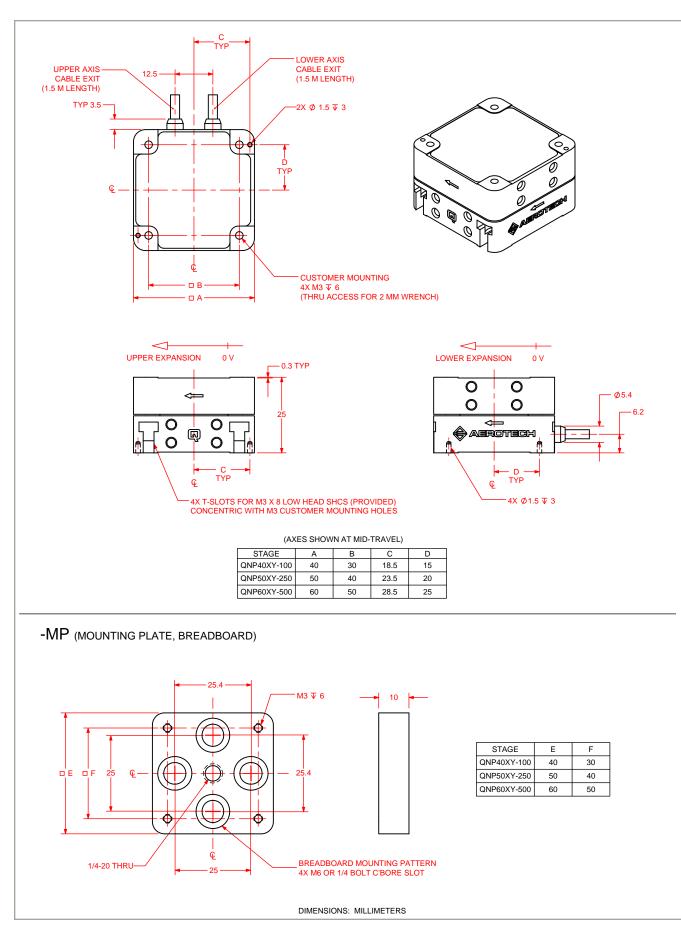
External elements are anodized aluminum. Some stainless steel components are used in the internal construction. Other materials upon request.
Specifications are measured centered and at a height of approximately 15 mm above the output carriage.

Electrical Specifications	QNP40XY-100	QNP50XY-250	QNP60XY-500
Drive System	Piezo Multi-Layer Stack Actuator		
Feedback	Closed Loop: Integrated Capacitive Sensor (-C) Open Loop: None (-)		
Voltage Range	-30 V to +150 V		
Piezo Stack Capacitance ⁽¹⁾	1.6 µF	2.3 μF	6.4 µF

Note:

1. Value ±20%

QNP-XY Series DIMENSIONS



Linear Piezo Stages QNP-XY Series

QNP-XY Series ORDERING INFORMATION

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QNP40XY-100	QNP40XY-100 two-axis XY piezo nanopositioning stage, 100 x 100 um CL travel
QNP50XY-250	QNP50XY-250 two-axis XY piezo nanopositioning stage, 250 x 250 um CL travel
QNP60XY-500	QNP60XY-500 two-axis XY piezo nanopositioning stage, 500 x 500 um CL travel

Feedback (Optional)

-C

-MP

Capacitance sensor feedback

Mounting Plate (Optional)

Mounting plate for English and metric optical breadboard tables

Integration (Required)

Aerotech offers both standard and custom integration services to help you get your system fully operational as quickly as possible. The following standard integration options are available for this system. Please consult Aerotech if you are unsure what level of integration is required, or if you desire custom integration support with your system

-TAS	Integration - Test as system Testing, integration, and documentation of a group of components as a complete system that will be used together (ex: drive, controller, and stage). This includes parameter file generation, system tuning, and documentation of the system configuration.
-TAC	Integration - Test as components Testing and integration of individual items as discrete components that ship together. This is typically used for spare parts, replacement parts, or items that will not be used together. These components may or may not be part of a larger system.

Adapter Plates (to be ordered as a separate line item)

AP-QNP250XY-100ZAdapter plate, lower: QNP250XY, upper: QNP100ZAP-QNP500XY-100Z-250ZAdapter plate, lower: QNP500XY, upper: QNP100Z/250Z